

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/684,436	AHN ET AL.	
	Examiner	Art Unit	Page 1 of 1
	Khoi H Tran	3651	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,923,352	05-1990	Tamura et al.	414/225.01
	B	US-5,303,482	04-1994	Yamashita et al.	34/80
	C	US-5,378,283	01-1995	Ushikawa, Harunori	118/719
	D	US-5,740,034	04-1998	Saeki, Hiroaki	700/59
	E	US-5,474,410	12-1995	Ozawa et al.	414/217
	F	US-5,536,320	07-1996	Ushikawa et al.	118/719
	G	US-5,829,939	11-1998	Iwai et al.	414/411
	H	US-5,876,280	03-1999	Kitano et al.	454/187
	I	US-5,997,398	12-1999	Yamada et al.	454/187
	J	US-6,477,440	11-2002	Davis, Shawn D.	700/123
	K	US-6,802,934	10-2004	Saeki et al.	156/345.31
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.